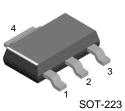


SEMICONDUCTOR®

# **FZT790A**

# **PNP Low Saturation Transistor**

• These devices are designed with high current gain and low saturation voltage with collector currents up to 3A continuous.



FZT790A

1. Base 2.4. Collector 3. Emitter

# Absolute Maximum Ratings \* T<sub>C</sub>=25°C unless otherwise noted

Parameter	Value	Units
Collector-Emitter Voltage	-40	V
Collector-Base Voltage	-50	V
Emitter-Base Voltage	-5	V
Collector Current - Continuous	-3	A
Operating and Storage Junction Temperature Range	- 55 ~ +150	°C
	Collector-Emitter Voltage     Collector-Base Voltage     Emitter-Base Voltage     Collector Current   - Continuous	Collector-Emitter Voltage -40   Collector-Base Voltage -50   Emitter-Base Voltage -5   Collector Current - Continuous   -3

#### NOTES:

These ratings are based on a maximum junction temperature of 150degrees C.
These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

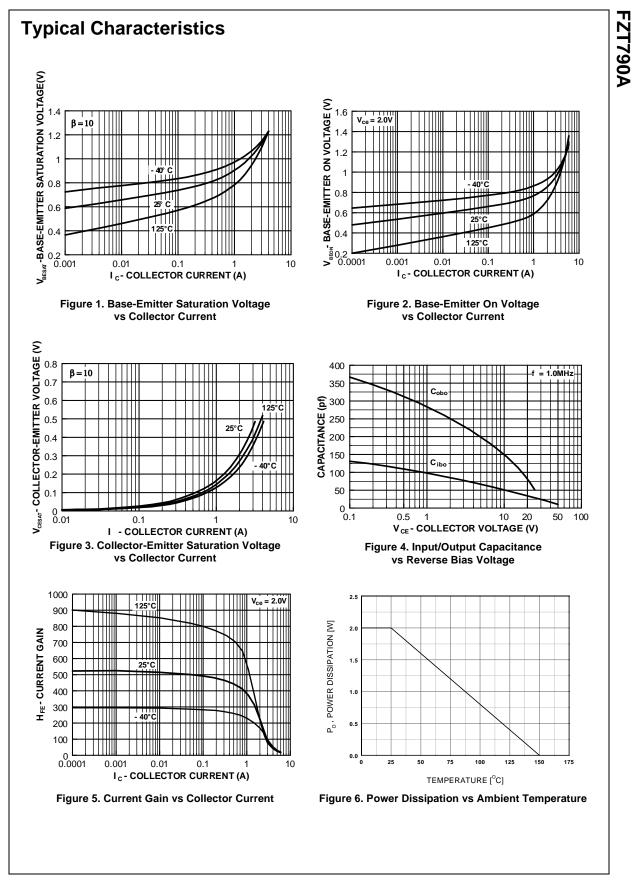
## Electrical Characteristics T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Max.	Units
Off Characte	eristics	· ·	•	•	
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> = -10mA, I <sub>B</sub> = 0	-40		V
BV <sub>CBO</sub>	Collector-Emitter Breakdown Voltage	$I_{\rm C} = -100\mu {\rm A}, I_{\rm E} = 0$	-50		V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_{\rm E} = -100\mu A, I_{\rm C} = 0$	-5.0		V
I <sub>CBO</sub>	Collector Cut-off Current	$V_{CB} = -30V, I_{E} = 0$		-100	nA
020		$V_{CB} = -30V, I_E = 0, T_A = 100^{\circ}C$		-10	μΑ
I <sub>EBO</sub>	Emitter Cut-off Current	$V_{EB} = -4V, I_{C} = 0$		-100	nA
On Characte	eristics *				
h <sub>FE</sub>	DC Current Gain	$V_{CE} = -2.0V, I_{C} = -10mA$	300	800	
		$V_{CE} = -2.0V, I_{C} = -500mA$	250		
		V <sub>CE</sub> = -2.0V, I <sub>C</sub> = -1.0A	200		
		$V_{CE} = -2.0V, I_{C} = -2.0A$	150		
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = -500mA, I <sub>B</sub> = -5.0mA		-0.25	mV
		I <sub>C</sub> = -1.0A, I <sub>B</sub> = -10mA		-0.45	
		I <sub>C</sub> = -2.0A, I <sub>B</sub> = -50mA		-0.75	
V <sub>BE(sat)</sub>	Base-Emitter Saturation Voltage	I <sub>C</sub> = -1.0A, I <sub>B</sub> = -10mA		-1.0	V
V <sub>BE(on)</sub>	Base-Emitter On Voltage	I <sub>C</sub> = -1.0A, V <sub>CE</sub> = -2.0V		-1.0	V
Small Signa	I Characteristics	•	•	•	
f <sub>T</sub>	Transition Frequency	$I_{C} = -50$ mA, $V_{CE} = -5.0$ V, f = 50MHz	100		MHz

# **Thermal Characteristics**

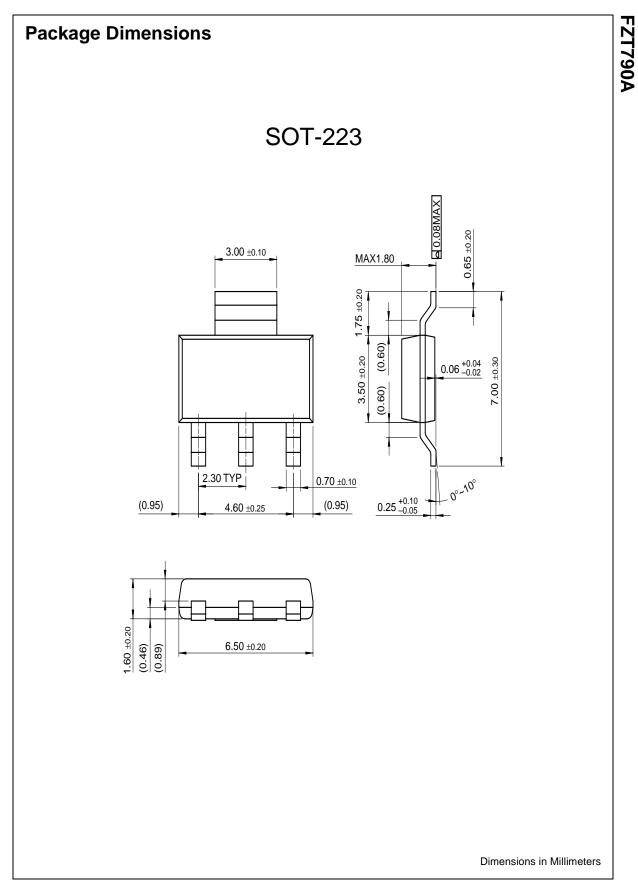
Symbol	Parameter	Max.	Units
PD	Total Device Dissipation	2	W
$R_{\thetaJA}$	R <sub>0JA</sub> Thermal Resistance, Junction to Ambient		°C/W

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### **Definition of Terms**

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